

# 4V Drive Nch + Nch MOSFET

## TT8K11

### ● Structure

Silicon N-channel MOSFET

### ● Features

- 1) Low on-resistance.
- 2) Low voltage drive(4V drive).
- 3) Small surface mount package(TSST8).

### ● Application

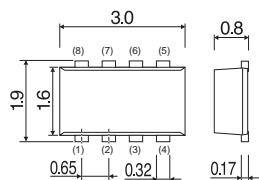
Switching

### ● Packaging specifications

Type	Package	Taping
	Code	TCR
	Basic ordering unit (pieces)	3000
TT8K11	○	

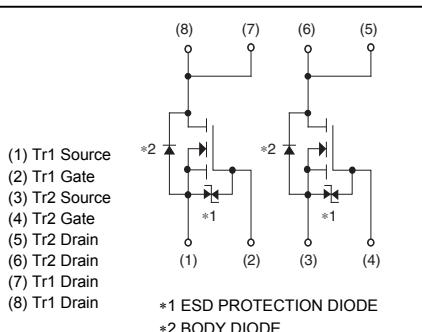
### ● Dimensions (Unit : mm)

TSST8



Abbreviated symbol : K11

### ● Inner circuit



### ● Absolute maximum ratings (Ta = 25°C)

<It is the same ratings for the Tr1 and Tr2.>

Parameter	Symbol	Limits	Unit
Drain-source voltage	V <sub>DSS</sub>	30	V
Gate-source voltage	V <sub>GSS</sub>	±20	V
Drain current	Continuous I <sub>D</sub>	±3	A
	Pulsed I <sub>DP</sub> *1	±12	A
Source current (Body Diode)	Continuous I <sub>s</sub>	0.8	A
	Pulsed I <sub>sp</sub> *1	12	A
Power dissipation	P <sub>D</sub> *2	1.25	W / TOTAL
		1.0	W / ELEMENT
Channel temperature	T <sub>ch</sub>	150	°C
Range of storage temperature	T <sub>stg</sub>	-55 to +150	°C

\*1 Pw≤10μs, Duty cycle≤1%

\*2 Mounted on a ceramic board.

### ● Thermal resistance

Parameter	Symbol	Limits	Unit
Channel to Ambient	R <sub>th</sub> (ch-a) <sup>*</sup>	100	°C / W / TOTAL
		125	°C / W / ELEMENT

\*Mounted on a ceramic board.

● Electrical characteristics (Ta = 25°C)

<It is the same characteristics for the Tr1 and Tr2.>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I <sub>GSS</sub>	-	-	±10	µA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	30	-	-	V	I <sub>D</sub> =1mA, V <sub>GS</sub> =0V
Zero gate voltage drain current	I <sub>DSS</sub>	-	-	1	µA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V
Gate threshold voltage	V <sub>GS(th)</sub>	1.0	-	2.5	V	V <sub>DS</sub> =10V, I <sub>D</sub> =1A
Static drain-source on-state resistance	R <sub>DS(on)</sub> *	-	51	71	mΩ	I <sub>D</sub> =3A, V <sub>GS</sub> =10V
		-	67	94		I <sub>D</sub> =3A, V <sub>GS</sub> =4.5V
		-	78	109		I <sub>D</sub> =3A, V <sub>GS</sub> =4V
Forward transfer admittance	Y <sub>fs</sub>  *	2.0	-	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =3A
Input capacitance	C <sub>iss</sub>	-	140	-	pF	V <sub>DS</sub> =10V
Output capacitance	C <sub>oss</sub>	-	55	-	pF	V <sub>GS</sub> =0V
Reverse transfer capacitance	C <sub>rss</sub>	-	28	-	pF	f=1MHz
Turn-on delay time	t <sub>d(on)</sub> *	-	5	-	ns	V <sub>DD</sub> =15V, I <sub>D</sub> =1.5A
Rise time	t <sub>r</sub> *	-	13	-	ns	V <sub>GS</sub> =4.5V
Turn-off delay time	t <sub>d(off)</sub> *	-	20	-	ns	R <sub>L</sub> =10Ω
Fall time	t <sub>f</sub> *	-	3	-	ns	R <sub>G</sub> =10Ω
Total gate charge	Q <sub>g</sub> *	-	2.5	-	nC	V <sub>DD</sub> =15V, I <sub>D</sub> =3A
Gate-source charge	Q <sub>gs</sub> *	-	0.8	-	nC	V <sub>GS</sub> =5V
Gate-drain charge	Q <sub>gd</sub> *	-	0.6	-	nC	

\*Pulsed

● Body diode characteristics (Source-Drain)

<It is the same characteristics for the Tr1 and Tr2.>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward Voltage	V <sub>SD</sub> *	-	-	1.2	V	I <sub>s</sub> =3A, V <sub>GS</sub> =0V

\*Pulsed

●Electrical characteristic curves ( $T_a=25^\circ\text{C}$ )

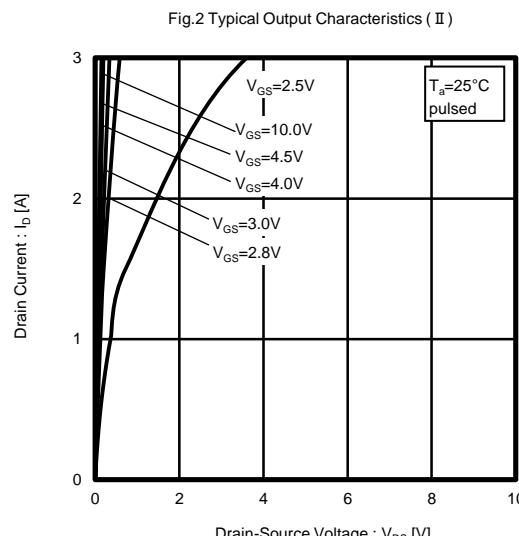
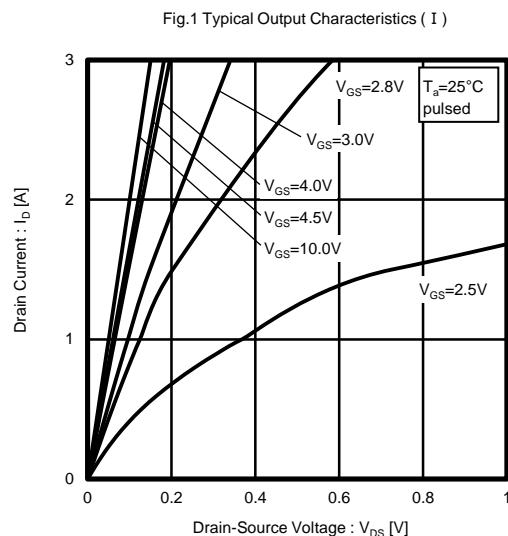


Fig.3 Static Drain-Source On-State Resistance vs. Drain Current

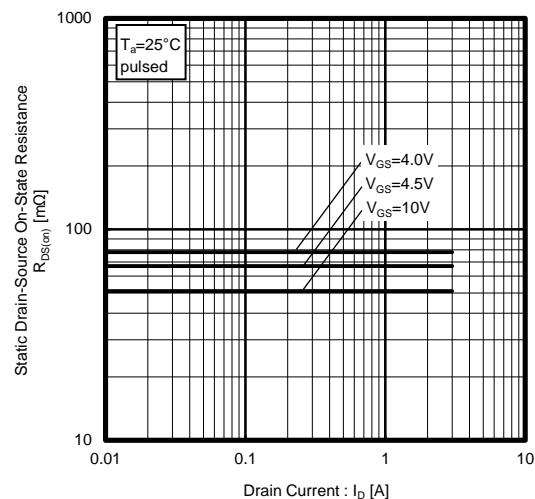


Fig.5 Static Drain-Source On-State Resistance vs. Drain Current

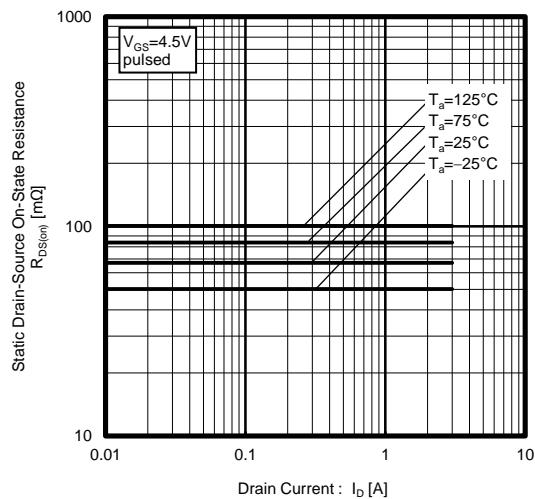


Fig.4 Static Drain-Source On-State Resistance vs. Drain Current

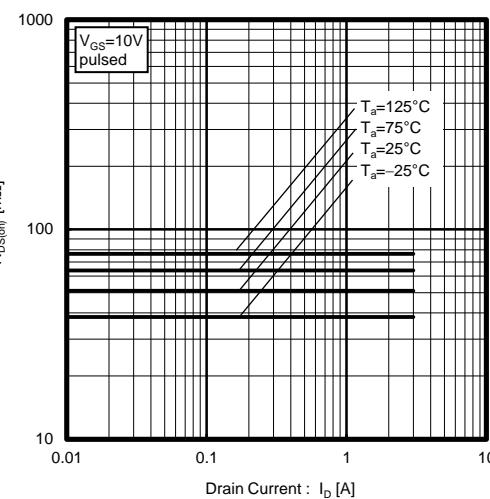


Fig.6 Static Drain-Source On-State Resistance vs. Drain Current

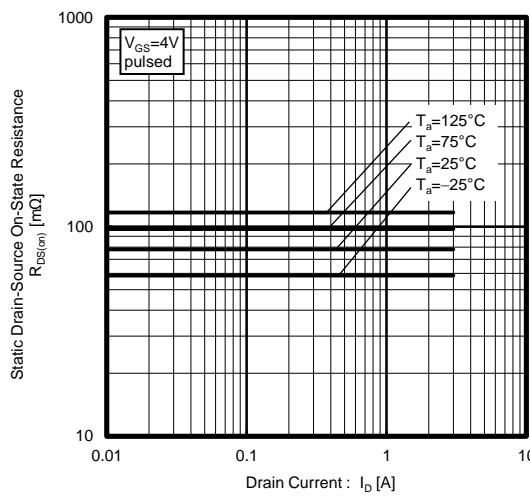


Fig.7 Forward Transfer Admittance vs. Drain Current

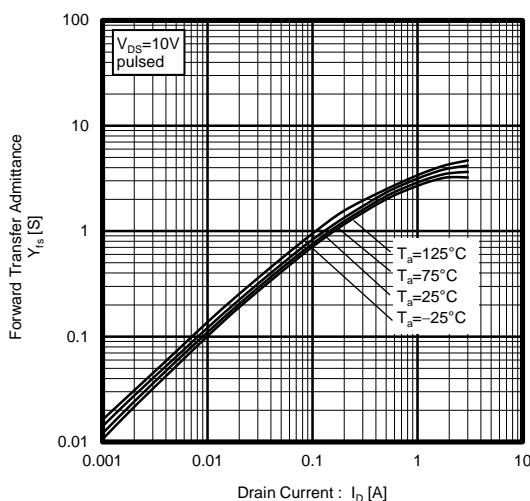


Fig.8 Typical Transfer Characteristics

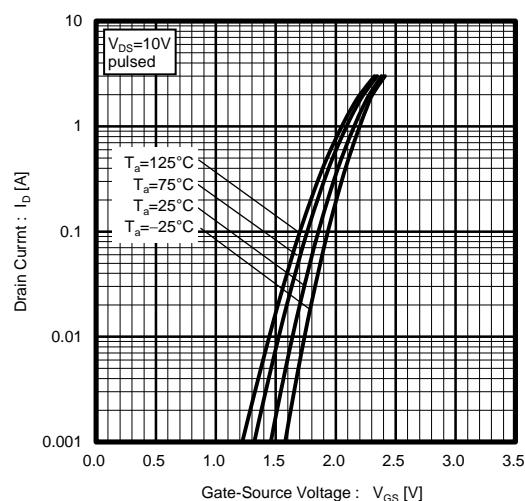


Fig.9 Source Current vs. Source-Drain Voltage

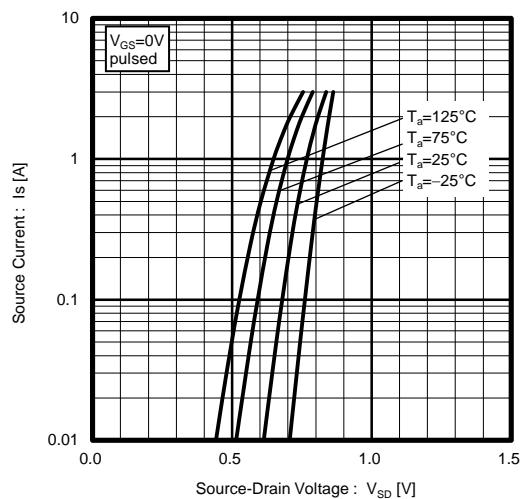


Fig.10 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

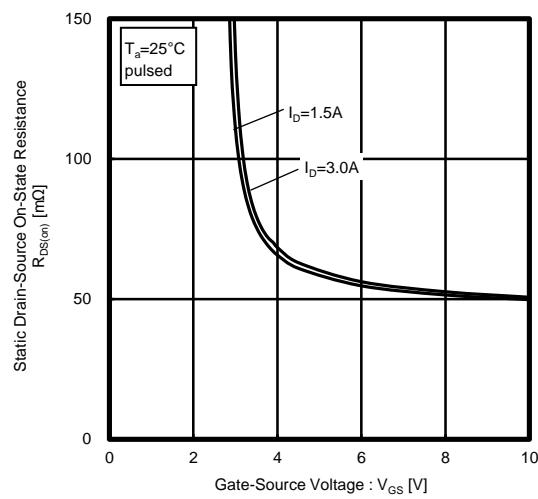


Fig.11 Switching Characteristics

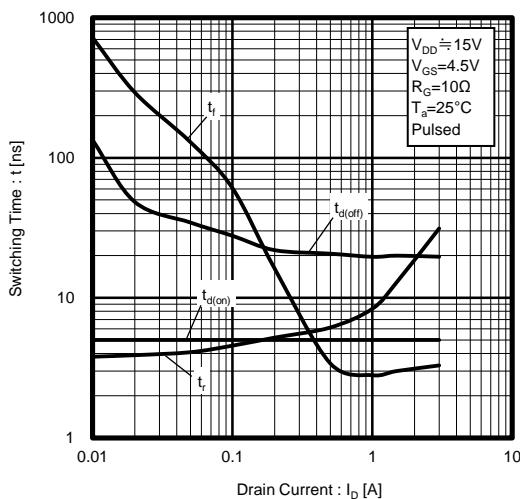


Fig.12 Dynamic Input Characteristics

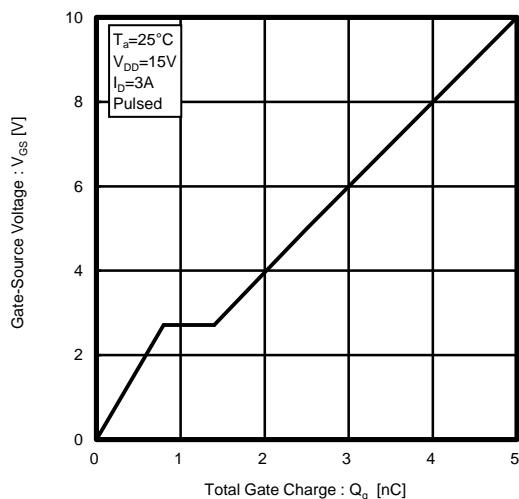


Fig.13 Typical Capacitance vs. Drain-Source Voltage

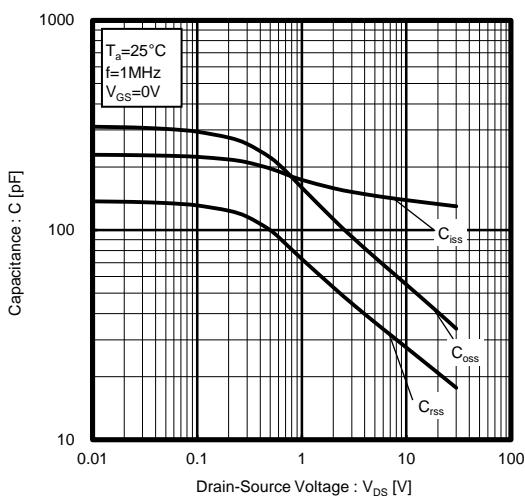


Fig.14 Maximum Safe Operating Area

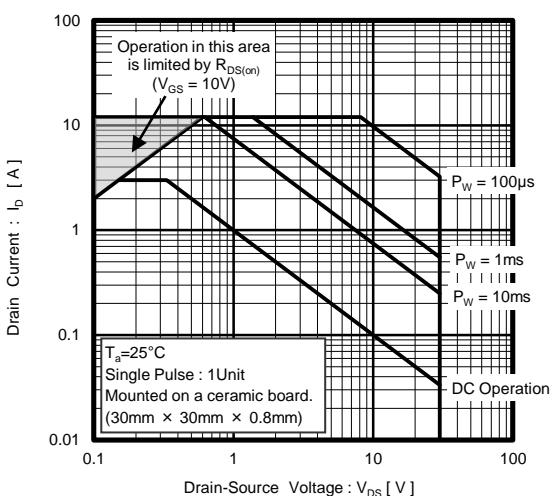
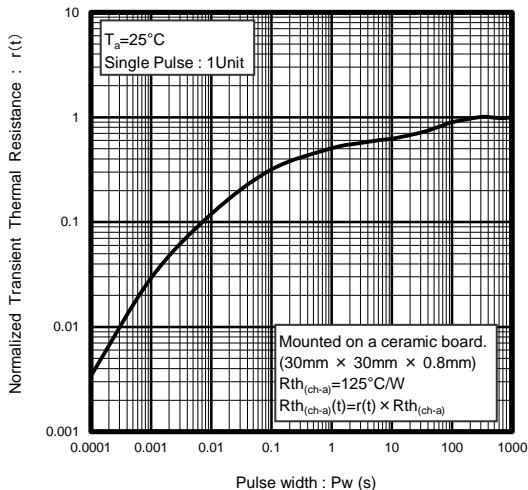


Fig.15 Normalized Transient Thermal Resistance v.s. Pulse Width



### ● Measurement circuits

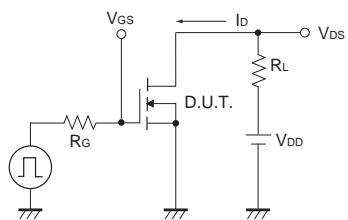


Fig.1-1 Switching Time Measurement Circuit

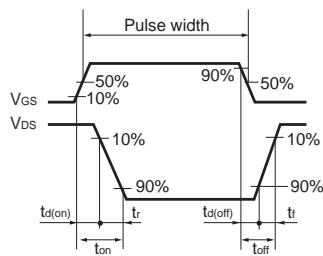


Fig.1-2 Switching Waveforms

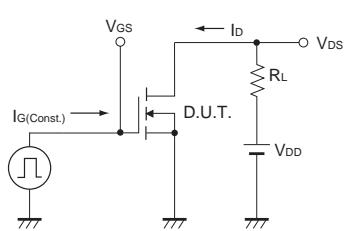


Fig.2-1 Gate Charge Measurement Circuit

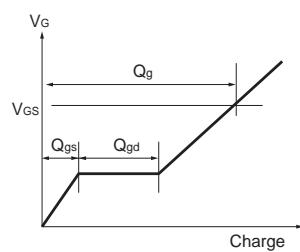


Fig.2-2 Gate Charge Waveform

### ● Notice

This product might cause chip aging and breakdown under the large electrified environment.  
Please consider to design ESD protection circuit.

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